Experience Our Connectivity...

# 3.3V ZERO DELAY BUFFER

FEBRUARY 2007 REV. P1.0.3

### **GENERAL DESCRIPTION**

#### **FUNCTIONAL DESCRIPTION**

XRK32308 is a 3.3V Zero Delay Buffer designed to distribute high-speed clocks in PC, workstation, datacom, telecom, and other high-performance applications.

The part has an on-chip PLL which locks to an input clock presented on the REF pin. The PLL feedback is required to be driven into the FB pin, and can be obtained from one of the outputs. The input-to-output skew is guaranteed to be less than 350 ps, and output-to-output skew is guaranteed to be less than 200 ps.

XRK32308 has two banks of four outputs each. These can be controlled by the Select inputs as shown in Table 2, "Select Input Decoding," on page 2. If all output clocks are not required, Bank B can be three-stated. The select inputs also allow the input clock to be directly applied to the output for chip and system testing purposes.

Multiple XRK32308 devices can accept the same input clock and distribute it in a system. In this case, the skew between the outputs of two devices is guaranteed to be less than 700 ps.

XRK32308 devices are available in five different configurations, as shown in Table 3, "Available XRK32308 Configurations," on page 3.

The XRK32308–1 is the base part, where the output frequencies equal the reference if there is no counter in the feedback path.

The XRK32308–1H is the high-drive version of the – 1. Rise and fall times on this device are faster.

The XRK32308–2 allows the user to obtain 1X, and 2X or X/2 depending on which Bank sources the FB signal.

The XRK32308–3 allows the user to obtain 4X and 2X frequencies or 1X and 2X.

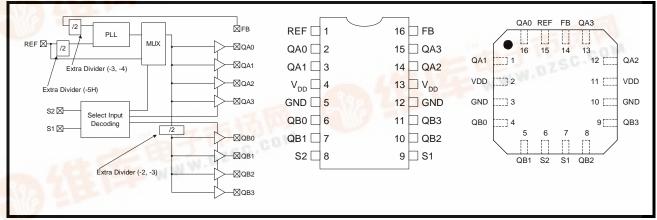
The XRK32308–4 enables the user to obtain 2X clocks on all outputs.

The XRK32308–5H is a high-drive version with REF/2 on both banks.

#### **FEATURES**

- Zero input-output propagation delay, adjustable by capacitive load on FB input
- Multiple configurations, see "Available XRK32308 Configurations" table
- Multiple low-skew outputs
- Two banks of four outputs, three-stateable by two select inputs
- 10-MHz to 120-MHz operating range
- 75ps typical cycle-to-cycle jitter (15pF, 66MHz)
- Space-saving 16-pin 150-mil SOIC package, 16-pin TSSOP or 16-pin QFN
- 3.3V operation
- Industrial and commercial temperature available









**TABLE 1: PIN DESCRIPTION** 

P	IN	SIGNAL	DESCRIPTION
SOIC/TSSOP	QFN	SIGNAL	DESCRIPTION
1	15	REF <sup>[1]</sup>	Input reference frequency
2	16	QA0 <sup>[2]</sup>	Clock output, Bank A
3	1	QA1 <sup>[2]</sup>	Clock output, Bank A
4	2	V <sub>DD</sub>	3.3V supply
5	3	GND	Ground
6	4	QB0 <sup>[2]</sup>	Clock output, Bank B
7	5	QB1 <sup>[2]</sup>	Clock output, Bank B
8	6	S2 <sup>[3]</sup>	Select input, bit 2
9	7	S1 <sup>[3]</sup>	Select input, bit 1
10	8	QB2 <sup>[2]</sup>	Clock output, Bank B
11	9	QB3 <sup>[2]</sup>	Clock output, Bank B
12	10	GND	Ground
13	11	$V_{DD}$	3.3V supply
14	12	QA2 <sup>[2]</sup>	Clock output, Bank A
15	13	QA3 <sup>[2]</sup>	Clock output, Bank A
16	14	FB	PLL feedback input

TABLE 2: SELECT INPUT DECODING

S2	S1	QA0-QA3	QB0-QB3	OUTPUT SOURCE
0	0	Three-State	Three-State	PLL
0	1	Driven	Three-State	PLL
1	0	Driven <sup>[4]</sup>	Driven <sup>[4]</sup>	Reference
1	1	Driven	Driven	PLL

# NOTES:

- 1. Weak pull-down.
- 2. Weak pull-down on all outputs.
- 3. Weak pull-ups on these inputs.
- 4. Outputs inverted on XRK32308–2 and XRK32308–3 in bypass mode, S2 = 1 and S1 = 0.

TABLE 3: AVAILABLE XRK32308 CONFIGURATIONS

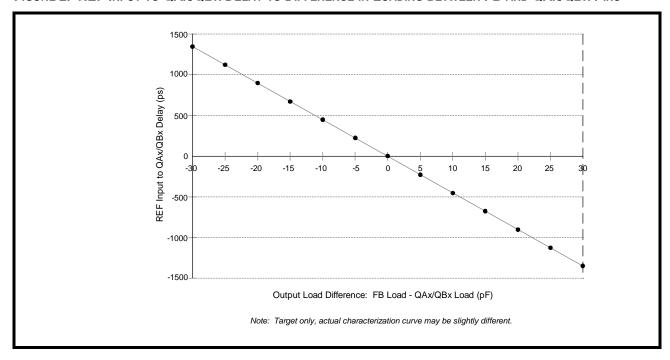
DEVICE	FEEDBACK FROM	BANK A FREQUENCY	BANK B FREQUENCY
XRK32308-1	Bank A or Bank B	Reference	Reference
XRK32308-1H	Bank A or Bank B	Reference	Reference
XRK32308-2	Bank A	Reference	Reference/2
XRK32308-2	Bank B	2 X Reference	Reference
XRK32308-3	Bank A	2 X Reference	Reference or Reference <sup>[5]</sup>
XRK32308-3	Bank B	4 X Reference	2 X Reference
XRK32308-4	Bank A or Bank B	2 X Reference	2 X Reference
XRK32308-5H	Bank A or Bank B	Reference/2	Reference/2

#### Notes:

5. Output phase is indeterminant (0° or 180° from input clock). If phase integrity is required, use the XRK32308–2.

#### ZERO DELAY AND SKEW CONTROL

FIGURE 2. REF INPUT TO QAX/QBX DELAY VS DIFFERENCE IN LOADING BETWEEN FB AND QAX/QBX PINS



To close the feedback loop of the XRK32308, the FB pin can be driven from any of the eight available output pins. The output driving the FB pin will be driving a total load of 7 pF plus any additional load that it drives. The relative loading of this output (with respect to the remaining outputs) can adjust the input-output delay. This is shown in the graph above.

For applications requiring zero input-output delay, all outputs including the one providing feedback should be equally loaded. If input-output delay adjustments are required, use the above graph to calculate loading differences between the feedback output and remaining outputs.

For zero output-output skew, be sure to load outputs equally.

TABLE 4: ABSOLUTE MAXIMUM RATINGS

Supply Voltage to Ground Potential	-0.5V to +7.0V
DC Input Voltage (Except Ref)	-0.5V to V <sub>DD</sub> +0.5V
DC Input Voltage REF	-0.5 to 7V
Storage Temperature	-65°C to +150°C
Junction Temperature	150°C
Static Discharge Voltage (per MIL-STD-883, Method 3015)	>2000V

TABLE 5: OPERATING CONDITIONS FOR XRK32308 COMMERCIAL TEMPERATURE DEVICES

PARAMETER	DESCRIPTION	Min	MAX	Unit
$V_{DD}$	Supply Voltage	3.0	3.6	V
T <sub>A</sub>	Operating Temperature (Ambient Temperature)	0	70	°C
C <sub>L</sub>	Load Capacitance, below 100MHz	-	30	pF
	Load Capacitance, from 100MHz to 120MHz	-	15	pF
C <sub>IN</sub>	Input Capacitance <sup>[6]</sup>	-	7	pF
t <sub>PU</sub>	Power-up time for all V <sub>DD</sub> s to reach minimum specified voltage (power ramps must be monotonic)	0.05	50	ms

### NOTES:

6. Applies to both Ref Clock and FB.

TABLE 6: ELECTRICAL CHARACTERISTICS FOR XRK32308 COMMERCIAL TEMPERATURE DEVICES

PARAMETER	DESCRIPTION	TEST CONDITIONS	Min	Max	Unit
$V_{IL}$	Input Low Voltage		-	0.8	V
V <sub>IH</sub>	Input High Voltage		2.0	-	V
I <sub>IL</sub>	Input Low Current	V <sub>IN</sub> =0V	-	50.0	μΑ
I <sub>IH</sub>	Input High Current	$V_{IN}=V_{DD}$	-	100.0	μΑ
V <sub>OL</sub>	Output Low Voltage <sup>[7]</sup>	I <sub>OL</sub> = 8mA (-1, -2, -3, -4) I <sub>OL</sub> = 12mA (-1H, -5H)	-	0.4	V
V <sub>OH</sub>	Output High Voltage <sup>[7]</sup>	I <sub>OH</sub> = -8mA (-1, -2, -3, -4) I <sub>OH</sub> = -12mA (-1H, -5H)	2.4	-	V

## 3.3V ZERO DELAY BUFFER

TABLE 6: ELECTRICAL CHARACTERISTICS FOR XRK32308 COMMERCIAL TEMPERATURE DEVICES

PARAMETER	DESCRIPTION	TEST CONDITIONS	Min	Max	Unit
I <sub>DD</sub>		Unloaded outputs, 100-MHz REF,	-	45.0	mA
	Supply Current	Select inputs at V <sub>DD</sub> or GND	-	70 (-1H, -5H)	mA
		Unloaded outputs, 66-MHz REF (-1, -2, -3, -4)	-	32.0	mA
		Unloaded outputs, 33-MHz REF (-1, -2, -3, -4)	-	18.0	mA

#### NOTES:

7. Parameter is guaranteed by design and characterization. Not 100% tested in production.

Table 7: Switching Characteristics for XRK32308 Commercial Temperature Devices  $^{[8]}$ 

PARAMETER	NAME	TEST CONDITIONS	Min	Түр	Max	Unit
		30-pF load, All devices	10	-	100	MHz
t <sub>1</sub>	Output Frequency	20-pF load, -1H, -5H devices <sup>[9]</sup>	10	-	120	MHz
		15-pF load, -1, -2, -3, -4 devices	10	-	120	MHz
DC	Duty Cycle <sup>[7]</sup> = $t_2 \div t_1$	Measured at 1.4V, F <sub>OUT</sub> =66.66MHz 30-pF load	40.0	50.0	60.0	%
DC	(-1, -2, -3, -4, -1H, -5H)	Measured at 1.4V, F <sub>OUT</sub> <50.0MHz 15-pF load	45.0	50.0	55.0	%
	Rise Time <sup>[7]</sup> (-1, -2, -3, -4)	Measured between 0.8V and 2.0V, 30-pF load	-	-	2.20	ns
t <sub>3</sub>		Measured between 0.8V and 2.0V, 15-pF load	-	-	1.50	ns
	Rise Time <sup>[7]</sup> (-1H, -5H)	Measured between 0.8V and 2.0V, 30-pF load	-	-	1.50	ns
	Fall Time <sup>[7]</sup>	Measured between 0.8V and 2.0V, 30-pF load	-	-	2.20	ns
t <sub>4</sub>	(-1, -2, -3, -4)	Measured between 0.8V and 2.0V, 15-pF load	-	-	1.50	ns
	Fall Time <sup>[7]</sup> (-1H, -5H)	Measured between 0.8V and 2.0V, 30-pF load	-	-	1.25	ns



TABLE 7: SWITCHING CHARACTERISTICS FOR XRK32308 COMMERCIAL TEMPERATURE DEVICES<sup>[8]</sup>

PARAMETER	NAME	TEST CONDITIONS	Min	ТҮР	Max	Unit
	Output to Output Skew on same Bank (-1, -2, -3, -4) <sup>[7]</sup>	All outputs equally loaded	-	-	200	ps
	Output to Output Skew (-1H, -5H) <sup>[7]</sup>	All outputs equally loaded	-	-	200	ps
t <sub>5</sub>	Output Bank A to Output Bank B Skew (-1, -4, -5H)	All outputs equally loaded	-	-	200	ps
	Output Bank A to Output Bank B Skew (-2, -3)	All outputs equally loaded	-	-	400	ps
t <sub>6</sub>	Delay, REF Rising Edge to FB Rising Edge <sup>[7]</sup>	Measured at V <sub>DD</sub> /2	-	0	<u>+</u> 250	ps
t <sub>7</sub>	Device to Device Skew <sup>[7]</sup>	Measured at V <sub>DD</sub> /2 on the FB pins of devices	-	0	700	ps
t <sub>8</sub>	Output Slew Rate <sup>[7]</sup>	Measured between 0.8V and 2.0V on -1H, -5H device using Test Circuit #2	1	-		V/ns
		Measured at 66.67MHz, loaded outputs, 15-pF load	-	75	200	ps
	Cycle to Cycle Jitter <sup>[7]</sup> (-1, -1H, -4, -5H)	Measured at 66.67MHz, loaded outputs, 30-pF load	-	-	200	ps
t <sub>J</sub>		Measured at 120MHz, loaded outputs, 15-pF load	-	-	100	ps
	Cycle to Cycle Jitter <sup>[7]</sup>	Measured at 66.67MHz, loaded outputs, 30-pF load	-	-	400	ps
	(-2, -3)	Measured at 66.67MHz, loaded outputs, 15-pF load	-	-	400	ps
t <sub>LOCK</sub>	PLL Lock Time <sup>[7]</sup>	Stable power suppy, valid clock presented on REF and FB pins	-	-	1.0	ms

### NOTES:

- 8. All parameters are specified with loaded outputs.
- 9. XRK32308 has maximum input frequency of 120MHz and maximum output of 66.67MHz.

## TABLE 8: OPERATING CONDITIONS FOR XRK32308 INDUSTRIAL TEMPERATURE DEVICES

PARAMETER	DESCRIPTION	Min	Max	Unit
$V_{DD}$	Supply Voltage	3.0	3.6	V
$T_A$	Operating Temperature (Ambient Temperature)	-40	85	°C
C <sub>L</sub>	Load Capacitance, below 100MHz	-	30	pF
ΟL	Load Capacitance, from 100MHz to 120MHz	-	15	pF
C <sub>IN</sub>	Input Capacitance <sup>[6]</sup>	-	7	pF
t <sub>PU</sub>	Power-up time for all V <sub>DD</sub> s to reach minimum specified voltage (power ramps must be monotonic)	0.05	50	ms

## TABLE 9: ELECTRICAL CHARACTERISTICS FOR XRK32308 INDUSTRIAL TEMPERATURE DEVICES

PARAMETER	DESCRIPTION	TEST CONDITIONS	Min	Max	Unit
$V_{IL}$	Input Low Voltage		-	0.8	V
V <sub>IH</sub>	Input High Voltage		2.0	-	V
I <sub>IL</sub>	Input Low Current	V <sub>IN</sub> =0V	-	50.0	μΑ
I <sub>IH</sub>	Input High Current	$V_{IN}=V_{DD}$	-	100.0	μΑ
V <sub>OL</sub>	Output Low Voltage <sup>[7]</sup>	I <sub>OL</sub> = 8mA (-1, -2, -3, -4) I <sub>OL</sub> = 12mA (-1H, -5H)	-	0.4	V
V <sub>OH</sub>	Output High Voltage <sup>[7]</sup>	I <sub>OH</sub> = -8mA (-1, -2, -3, -4) I <sub>OH</sub> = -12mA (-1H, -5H)	2.4	-	V
		Unloaded outputs, 100 MHz REF, Select inputs at V <sub>DD</sub> or GND	-	45.0	mA
	Supply Current		-	70 (-1H, -5H)	mA
I <sub>DD</sub>		Unloaded outputs, 66-MHz REF (-1, -2, -3, -4)	-	35.0	mA
		Unloaded outputs, 33-MHz REF (-1, -2, -3, -4)	-	20.0	mA

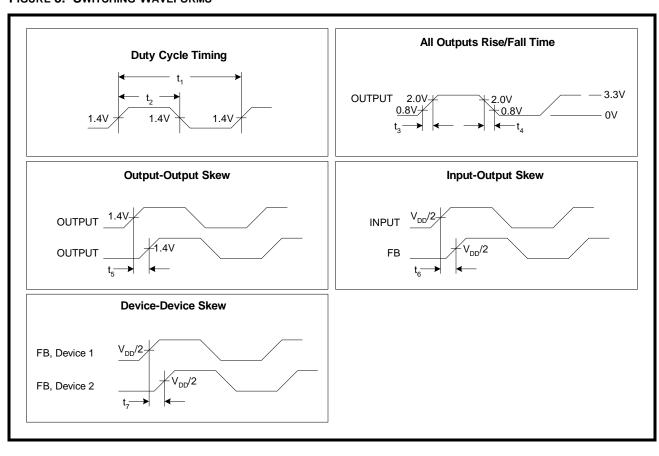
PARAMETER	NAME	TEST CONDITIONS	Min	ТҮР	Max	Unit
		30-pF load, All devices	10	-	100	MHz
t <sub>1</sub>	Output Frequency	20-pF load, -1H, -5H devices <sup>[9]</sup>	10	-	120	MHz
		15-pF load, 01, 02, 03, 04 devices	10	-	120	MHz
DC	Duty Cycle <sup>[7]</sup> = $t_2 \div t_1$	Measured at 1.4V, F <sub>OUT</sub> =66.66MHz 30-pF load	40.0	50.0	60.0	%
ВС	(-1, -2, -3, -4, -1H, -5H)	Measured at 1.4V, F <sub>OUT</sub> <50.0MHz 15-pF load	45.0	50.0	55.0	%
	Rise Time <sup>[7]</sup>	Measured between 0.8V and 2.0V, 30-pF load	-	-	2.5	ns
t <sub>3</sub>	(-1, -2, -3, -4)	Measured between 0.8V and 2.0V, 15-pF load	-	-	1.50	ns
	Rise Time <sup>[7]</sup> (-1H, -5H)	Measured between 0.8V and 2.0V, 30-pF load	-	-	1.50	ns
	Fall Time <sup>[7]</sup> (-1, -2, -3, -4)	Measured between 0.8V and 2.0V, 30-pF load	-	-	2.50	ns
t <sub>4</sub>		Measured between 0.8V and 2.0V, 15-pF load	-	-	1.50	ns
	Fall Time <sup>[7]</sup> (-1H, -5H)	Measured between 0.8V and 2.0V, 30-pF load	-	-	1.25	ns
	Output to Output Skew on same Bank (-1, -2, -3, -4) <sup>[7]</sup>	All outputs equally loaded	-	-	200	ps
	Output to Output Skew (-1H, -5H)	All outputs equally loaded	-	-	200	ps
t <sub>5</sub>	Output Bank A to Output Bank B Skew (-1, -4, -5H)	All outputs equally loaded	-	-	200	ps
	Output Bank A to Output Bank B Skew (-2, -3)	All outputs equally loaded	-	-	400	ps
t <sub>6</sub>	Delay, REF Rising Edge to FB Rising Edge <sup>[7]</sup>	Measured at V <sub>DD</sub> /2	-	0	<u>+</u> 250	ps
t <sub>7</sub>	Device to Device Skew <sup>[7]</sup>	Measured at V <sub>DD</sub> /2 on the FB pins of devices	-	0	700	ps
t <sub>8</sub>	Output Slew Rate <sup>[7]</sup>	Measured between 0.8V and 2.0V on -1H, -5H device using Test Circuit #2	1	-		V/ns

REV. P1.0.3

TABLE 10: SWITCHING CHARACTERISTICS FOR XRK32308 INDUSTRIAL TEMPERATURE DEVICES<sup>[8]</sup>

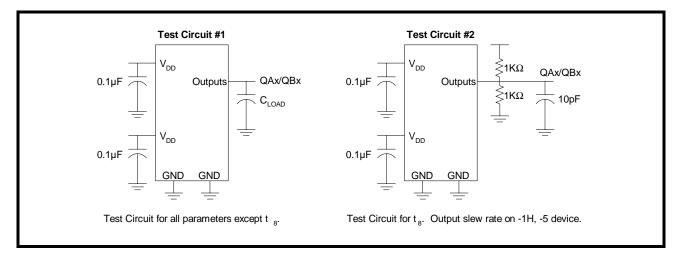
PARAMETER	NAME	TEST CONDITIONS	Min	Түр	Max	Unit
t <sub>J</sub>	Cycle to Cycle Jitter <sup>[7]</sup> (-1, -1H, -4, -5H)	Measured at 66.67MHz, loaded outputs, 15-pF load	-	75	200	ps
		Measured at 66.67MHz, loaded outputs, 30-pF load	-	-	200	ps
		Measured at 120MHz, loaded outputs, 15-pF load	-	-	100	ps
	Cycle to Cycle Jitter <sup>[7]</sup>	Measured at 66.67MHz, loaded outputs, 30-pF load	-	-	400	ps
	(-2, -3)	Measured at 66.67MHz, loaded outputs, 15 pF load	-	-	400	ps
tLOCK	PLL Lock Time <sup>[7]</sup>	Stable power suppy, valid clocks presented on REF and FB pins	-	-	1.0	ms

## FIGURE 3. SWITCHING WAVEFORMS



REV. P1.0.3

# FIGURE 4. TEST CIRCUIT



# **TABLE 11: ORDERING INFORMATION**

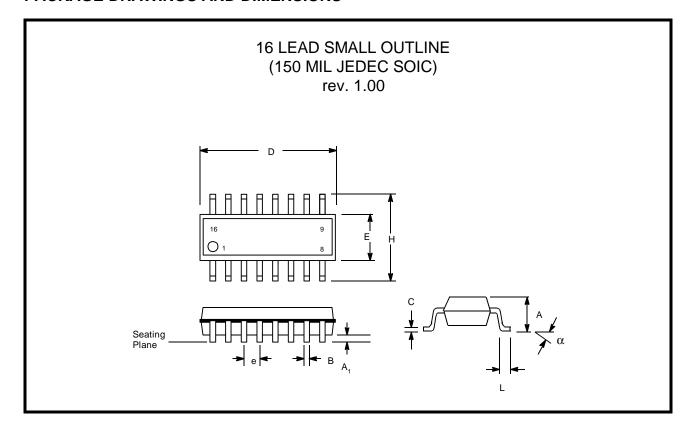
PART ORDERING NUMBER	PACKAGE TYPE	OPERATING TEMPERATURE RANGE	
XRK32308CD-1	16 Pin SOIC	0° to +70°	
XRK32308CDTR-1	16 Pin SOIC	0° to +70°	
XRK32308ID-1	16 Pin SOIC	-40° to +85°	
XRK32308IDTR-1	16 Pin SOIC	-40° to +85°	
XRK32308CL-1	16 Pin QFN	0° to +70°	
XRK32398IL-1	16 Pin QFN	-40° to +85°	
XRK32308CD-1H	16 Pin SOIC	0° to +70°	
XRK32308CDTR-1H	16 Pin SOIC	0° to +70°	
XRK32308ID-1H	16 Pin SOIC	-40° to +85°	
XRK32308IDTR-1H	16 Pin SOIC	-40° to +85°	
XRK32308CG-1H	16 Pin TSSOP	0° to +70°	
XRK32308CGTR-1H	16 Pin TSSOP	0° to +70°	
XRK32308IG-1H	16 Pin TSSOP	-40° to +85°	
XRK32308IGTR-1H	16 Pin TSSOP	-40° to +85°	
XRK32308CL-1H	16 Pin QFN	0° to +70°	
XRK32308IL-1H	16 Pin QFN	-40° to +85°	
XRK32308CD-2	16 Pin SOIC	0° to +70°	
XRK32308CDTR-2	16 Pin SOIC	0° to +70°	
XRK32308ID-2	16 Pin SOIC	-40° to +85°	
XRK32308IDTR-2	16 Pin SOIC	-40° to +85°	
XRK32308CL-2	16 Pin QFN	0° to +70°	
XRK32308IL-2	16 Pin QFN	-40° to +85°	
XRK32308CD-3	16 Pin SOIC	0° to +70°	
XRK32308CDTR-3	16 Pin SOIC	0° to +70°	
XRK32308ID-3	16 Pin SOIC	-40° to +85°	
XRK32308IDTR-3	16 Pin SOIC	-40° to +85°	
XRK32308CL-3	16 Pin QFN	0° to +70°	
XRK32308IL-3	16 Pin QFN	-40° to +85°	
XRK32308CD-4	16 Pin SOIC	0° to +70°	
XRK32308CDTR-4	16 Pin SOIC	0° to +70°	
XRK32308ID-4	16 Pin SOIC	-40° to +85°	
XRK32308IDTR-4	16 Pin SOIC	-40° to +85°	



**TABLE 11: ORDERING INFORMATION** 

PART ORDERING NUMBER	PACKAGE TYPE	OPERATING TEMPERATURE RANGE
XRK32308CL-4	16 Pin QFN	0° to +70°
XRK32308IL-4	16 Pin QFN	-40° to +85°
XRK32308CD-5H	16 Pin SOIC	0° to +70°
XRK32308CDTR-5H	16 Pin SOIC	0° to +70°
XRK32308CL-5H	16 Pin QFN	0° to +70°
XRK32308IL-5H	16 Pin QFN	-40° to +85°

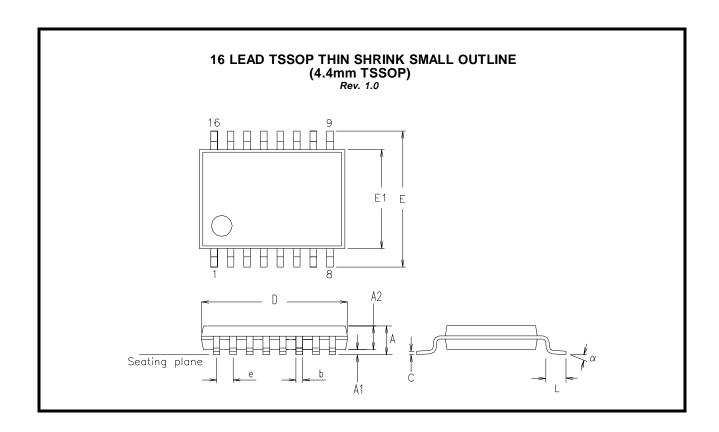
# **PACKAGE DRAWINGS AND DIMENSIONS**



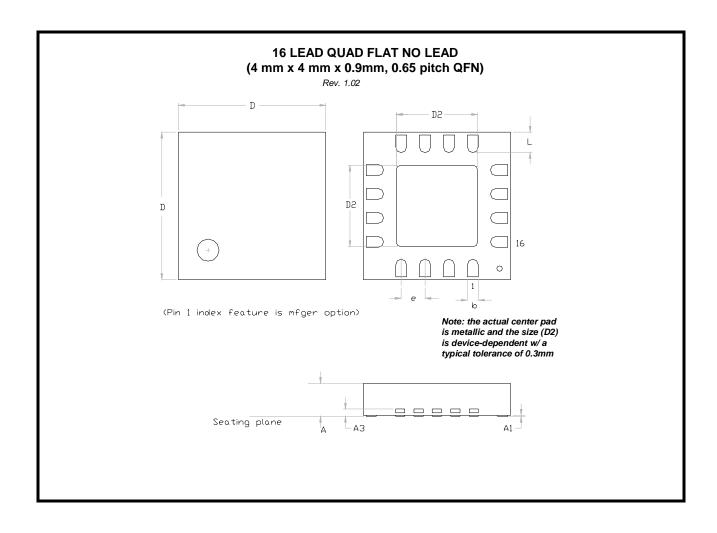
Note: The control dimension is the millimeter column

	INCHES		MILLIN	IETERS
SYMBOL	MIN	MAX	MIN	MAX
А	0.053	0.069	1.35	1.75
A <sub>1</sub>	0.004	0.010	0.10	0.25
В	0.013	0.020	0.33	0.51
С	0.007	0.010	0.19	0.25
D	0.386	0.394	9.80	10.00
Е	0.150	0.157	3.80	4.00
е	0.050 BSC		1.27 BSC	
Н	0.228	0.244	5.80	6.20
L	0.016	0.050	0.40	1.27
α	0°	8°	0°	8°





	INCHES		MILLIN	IETERS
SYMBOL	MIN	MAX	MIN	MAX
Α	0.031	0.043	0.80	1.10
A1	0.002	0.006	0.05	0.15
A2	0.031	0.037	0.80	0.95
В	0.007	0.012	0.19	0.30
С	0.004	0.008	0.09	0.20
D	0.193	0.201	4.90	5.10
Е	0.248	0.260	6.30	6.60
E1	0.169	0.177	4.30	4.50
е	0.0256 BSC		0.65	BSC
L	0.018	0.030	0.45	0.75
α	0°	8°	0°	8°



Note: The control dimension is in millimeter.

SYMBOL	INCHES		MILLIMETERS	
STIVIDUL	MIN	MAX	MIN	MAX
Α	0.031	0.039	0.80	1.00
A1	0.000	0.002	0.00	0.05
А3	0.000	0.008	0.00	0.20
D	0.154	0.161	3.90	4.10
D2	0.087	0.102	2.20	2.60
b	0.010	0.014	0.25	0.35
е	0.0256 BSC		0.65	BSC
L	0.018	0.026	0.026 0.45 0.65	

### PRELIMINARY



### 3.3V ZERO DELAY BUFFER

#### 3.3V ZERO DELAT BOTTE

### **REVISIONS**

Rev. #	DATE	DESCRIPTION OF CHANGES
P1.0.0	04/05/06	Initial release.
P1.0.1	04/21/06	Ordering information edit: Added "H" to last two product numbers.
P1.0.2	05/12/06	Operating range changed to 10MHz to 120MHz - edit all references of this.
P1.0.3	02/01/07	Add QFN package.

### **NOTICE**

EXAR Corporation reserves the right to make changes to the products contained in this publication in order to improve design, performance or reliability. EXAR Corporation assumes no responsibility for the use of any circuits described herein, conveys no license under any patent or other right, and makes no representation that the circuits are free of patent infringement. Charts and schedules contained here in are only for illustration purposes and may vary depending upon a user's specific application. While the information in this publication has been carefully checked; no responsibility, however, is assumed for inaccuracies.

EXAR Corporation does not recommend the use of any of its products in life support applications where the failure or malfunction of the product can reasonably be expected to cause failure of the life support system or to significantly affect its safety or effectiveness. Products are not authorized for use in such applications unless EXAR Corporation receives, in writing, assurances to its satisfaction that: (a) the risk of injury or damage has been minimized; (b) the user assumes all such risks; (c) potential liability of EXAR Corporation is adequately protected under the circumstances.

Copyright 2007 EXAR Corporation

Datasheet February 2007.

Reproduction, in part or whole, without the prior written consent of EXAR Corporation is prohibited.